


<b>Search Notes</b>  	<b>Application/Control No.</b>  10574417	<b>Applicant(s)/Patent Under Reexamination</b>  KUSANO ET AL.
	<b>Examiner</b>  STEPHAN ESSEX	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner
429	26, 34	6/16/2009	SJE

SEARCH NOTES		
Search Notes	Date	Examiner
EAST see search history	6/16/2009	SJE
Inventor search	6/16/2009	SJE
Consulted Dah-Wei Yuan	6/16/2009	SJE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/STEPHAN ESSEX/  
Examiner, Art Unit 1795